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High-Resolution Raman and Luminescence Spectroscopy of Isotope-Pure $^{28}$Si$^{12}$C, Natural and $^{13}$C – Enriched 4H-SiC

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**Keywords:** isotope-pure SiC, isotope-enriched SiC, Raman spectroscopy, photoluminescence, bandgap variation with isotope content

**Abstract.** The optical properties of isotope-pure $^{28}$Si$^{12}$C, natural SiC and enriched with $^{13}$C isotope samples of the 4H polytype are studied by means of Raman and photoluminescence spectroscopies. The phonon energies of the Raman active phonons at the $\Gamma$ point and the phonons at the M point of the Brillouin zone are experimentally determined. The excitonic bandgaps of the samples are accurately derived using tunable laser excitation and the phonon energies obtained from the photoluminescence spectra. Qualitative comparison with previously reported results on isotope-controlled Si is presented.

**Introduction**

Replacement of natural SiC with isotope-pure silicon carbide composed exclusively of $^{12}$C and $^{28}$Si is expected to improve the performance of this material in several applications. The improved thermal conductivity (presumably, up to 30%) will boost the performance of electronic and optoelectronic components and make them more economic due to reduced need of cooling. A number of other known applications will also benefit from the isotope purity, e.g., shielding of nuclear fuel particles with pure $^{28}$Si$^{12}$C is expected to solve the problem with conversion of $^{30}$Si to P during nuclear reactions, which eventually leads to cracking the shield. Also, isotope-pure $^{12}$C$^{28}$Si has obvious advantage for spintronics applications owing to the absence of nuclear spins in the crystal matrix. It has been shown recently as well that isotope-pure graphene has by ~20% larger thermal conductivity (at 300 K) than its counterpart containing carbon in its natural abundance [1], and similar anticipation can be made for graphene grown by sublimation on $^{28}$Si$^{12}$C. Recent measurements on 4H-$^{28}$Si$^{12}$C have estimated at least 18% improvement of the thermal conductivity at room temperature compared to natural 4H-SiC [2]. This study is concerned with comparative investigation of the optical properties of natural and isotope-controlled samples of 4H-SiC, including accurate determination of the phonon energies and the excitonic bandgap.

**Experimental Details**

The investigated 4H-SiC samples include isotope-purified $^{28}$Si$^{12}$C samples [with isotope purity 99.85% for $^{28}$Si and 99.98% for $^{12}$C as determined by secondary ion mass spectrometry (SIMS)], $^{13}$C-enriched sample (~50% $^{13}$C as determined by SIMS), and a reference sample with natural isotope abundance ($^{nat}$SiC with 98.9% $^{12}$C and 1.1% $^{13}$C, and 92.2% $^{28}$Si, 4.7% $^{29}$Si, and 3.1% $^{30}$Si). Most of the optical measurements are performed in a double monochromator (SPEX 1404) coupled to photomultiplier with maximum resolution of 0.05 Å (about 42 µeV in the near-bandgap region of 4H-SiC) using tunable laser excitation. Micro-Raman measurements are also employed for accurate determination of the relative shifts of the Raman peaks depending on the isotope composition. The substrate was removed from the investigated samples, however, polishing-induced stress lead to broadening of the no-phonon lines in the low-temperature photoluminescence spectrum. Hence,
another $^{28}\text{Si}^{12}\text{C}$ sample with the substrate on was used for measurements of the linewidth of the nitrogen-bound exciton no-phonon lines. However, no polishing-induced broadening could be observed in the Raman lines.

**Results and Discussion**

**Raman spectra.** All Raman measurements are performed in backscattering geometry. However, different configurations with respect to the crystal axis (c-axis) of the 4H-SiC samples were used in order to obtain information of all phonon modes allowed in Raman scattering. Using the labeling of the phonons according to the irreducible representation of the point group $C_{6v}$, the Raman-active phonons are $3A_1 + 3E_1 + 4E_2$ (the $3A_1 + 3E_1$ modes are also active in infrared absorption). Thus, a total of ten lines are expected in the Raman spectrum, but not all of them appear if a single experimental geometry is used. In addition, the splittings in the folded transversal acoustic modes have never been observed and a total of eight lines appear in the Raman spectra of 4H-SiC [3].

Typical Raman spectra in the conventional backscattering from the surface geometry demonstrating the peak shifts for the different samples are presented in Fig. 1. The absolute peak positions are summarized in Table 1. We notice that although the error in determination of the peak positions is ± 0.2 cm$^{-1}$, this error is systematic across all data rather than random. Hence, the peak shifts with respect to the isotope-pure $^{28}\text{Si}^{12}\text{C}$ have much better accuracy, probably below 0.05 cm$^{-1}$ (except for the broader LO and TO modes in the $^{13}\text{C}$-enriched sample). These shifts and the line broadening (the line widths are also displayed in Table 1) are due to differences in the isotope composition, as discussed below.

The stiffest modes (highest Raman shifts) for all the lines are observed in the $^{28}\text{Si}^{12}\text{C}$ sample, as expected in view of the “lightening” of the atomic weight of both atomic species and the intuitive anticipation that the squared vibrational frequency would scale as the inverse of the atomic mass. Useful approximation used to describe the effect of mass disorder due to presence of different isotopes in any of the C or Si sublattices is the virtual crystal approximation (VCA) [4], although much more accurate theory exists for elemental crystals, e.g., diamond [5]. Hereafter we use the notations of [3,4] for the folded modes (e.g., FLA(x) for longitudinal and FTA(x) for transversal acoustic modes, respectively, with x=0, 2/4 or 4/4 for 4H-SiC, etc.). The frequencies of the TO(0) and LO(0) modes in the notations of [3,4] in the $^{13}\text{C}$-enriched should scale according to VCA as the inverse square root of the reduced mass, $M_r = \overline{M}_C^{-1} + \overline{M}_Si^{-1}$, where $\overline{M}_C = 12 + x/100$ and $\overline{M}_Si = 28 + y_1/100 + 2y_2/100$ are the average masses (in amu) for C and Si in SiC containing $x\%^{13}\text{C}$, $y_1\%^{29}\text{Si}$, and $y_2\%^{30}\text{Si}$. Using as a reference the energies of TO(0) and LO(0) in $^{28}\text{Si}^{12}\text{C}$, the calculated frequencies for the other two samples are given in Table 1. Another mode, FLA(1), appearing around 610 cm$^{-1}$ in 4H-SiC has the special property that the displacements of the C atoms nearly vanish for this mode [6,7]. This explains the same (within the experimental accuracy) position of this mode in the Raman spectra of the $^{nat}\text{SiC}$ and $^{13}\text{C}$-enriched SiC (610.2 cm$^{-1}$), since both samples have the same natural abundance of Si isotopes. Hence the VCA can be applied but with different
mass factor for scaling the $^{28}\text{Si}^{12}\text{C}$-energy, namely, the ratio $\sqrt{M_{\text{Si}}/M_{\text{Si}}}$ involving Si masses only, where $M_{\text{Si}}=28$ amu is the $^{28}\text{Si}$ isotope mass. In most cases VCA produces only rough estimation of the experimental phonon energies, similar to the case of diamond [5].

Table 1. Raman shifts [cm$^{-1}$] for the investigated samples. The linewidths (FWHM) of the TO modes are shown below each mode. The calculated theoretical phonon energies are results of the VCA calculation and are given in parentheses after the experimental ones with a subscript T (where applicable, as explained in text).

<table>
<thead>
<tr>
<th>Phonon</th>
<th>FTA(2/4)</th>
<th>FTA(4/4)</th>
<th>FLA(4/4)</th>
<th>FTO(2/4)</th>
<th>TO(0)</th>
<th>LO(0)</th>
</tr>
</thead>
<tbody>
<tr>
<td>$^{28}\text{Si}^{12}\text{C}$</td>
<td>196.4, 204.6</td>
<td>265.6</td>
<td>611.1</td>
<td>777.2</td>
<td>798.2</td>
<td>965.1</td>
</tr>
<tr>
<td>natSiC</td>
<td>196.0, 204.25</td>
<td>265.05</td>
<td>610.2(609.9$^T$)</td>
<td>776.7(776.5$^T$)</td>
<td>797.9(797.5$^T$)</td>
<td>964.2(964.2$^T$)</td>
</tr>
<tr>
<td>$^{13}\text{C}$-enriched</td>
<td>194.4, 202.7</td>
<td>262.8</td>
<td>610.2(609.9$^T$)</td>
<td>~756(765.8$^T$)</td>
<td>~784(786.5$^T$)</td>
<td>~945(950.9$^T$)</td>
</tr>
<tr>
<td>FWHM &lt; 0.8</td>
<td>&lt; 0.8</td>
<td>&lt; 0.8</td>
<td>&lt; 0.8</td>
<td>FWHM 2.2</td>
<td>FWHM 2.3</td>
<td>FWHM ~3.6</td>
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<tr>
<td>FWHM &lt; 0.8</td>
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<td>&lt; 0.8</td>
<td>&lt; 0.8</td>
<td>FWHM 2.3</td>
<td>FWHM 2.4</td>
<td>FWHM ~3.6</td>
</tr>
<tr>
<td>FWHM &lt; 0.8</td>
<td>&lt; 0.8</td>
<td>&lt; 0.8</td>
<td>&lt; 0.8</td>
<td>FWHM &gt;13</td>
<td>FWHM 6.3</td>
<td>FWHM ~4.6</td>
</tr>
</tbody>
</table>

The observed linewidths of the Raman lines also deserve attention. While the optical modes exhibit significant broadening in the natSiC and especially the $^{13}\text{C}$-enriched samples compared to the $^{28}\text{Si}^{12}\text{C}$ sample, no broadening could be detected for the folded acoustic modes (FLA, FTA). The latter are very narrow, with linewidths below 0.25 cm$^{-1}$ in natSiC [3]. The main mechanism of line broadening is elastic scattering of the phonons induced by mass defects [4]; according to the theory [8] the magnitude of the broadening $\Delta \Gamma$ of a mode with frequency $\omega$ is proportional to $\Delta \Gamma \sim \Omega^2 |\mathbf{g}|^4 \rho(\omega)$, where $\rho(\omega)$ is the phonon density of states, $\mathbf{g}$ is the relevant phonon eigenvector and $\Omega$ is the relative mass variance. In the case of FLA and FTA modes the weight of the Si eigenvector dominates in $\mathbf{g}$ and the relative mass variance is much smaller for Si than for C. In addition, the factor $\Omega^2$ contributes another order of magnitude in diminishing $\Delta \Gamma$ for the low-energy modes in comparison to the optical modes, which explains why the isotope-induced broadening is not observed with our experimental resolution (about 0.8 cm$^{-1}$).

The optical modes are fitted with convolution of Lorentzian and triangular line shapes with the linewidth of the latter fixed at the spectrometer resolution (0.8 cm$^{-1}$). The resulting widths of the Lorentzians are listed in Table 1 and are in overall agreement with the semi-empirical theoretical curves of Ref. [4] (cf. Fig. 3 of this reference).

**Photoluminescence (PL) and excitonic bandgap determination.** The low-temperature PL spectra of the three investigated samples are compared in Fig. 2. High-resolution measurement reveals that the linewidth of the nitrogen bound exciton (NBE) no-phonon line ($Q_0$) of the $^{28}\text{Si}^{12}\text{C}$ sample is smaller (possibly, much smaller) than the maximum achievable spectral resolution in our system (0.05 Å, or ~45 µeV, see the insert of Fig. 2), while the corresponding line is significantly broader in the other two samples. The phonon replicas of the shallower NBE line $P_0$ and the free exciton replicas are clearly visible in the spectra. Two observations are worth mentioning before proceeding with the excitonic-bandgap determination. We notice a shift of the NBE lines with increasing energy, namely, the ratio $E_{33}/E_{33}$ of 33.15 ± 0.05, 33.10 ± 0.05, and 32.90 ± 0.05 meV, respectively. The rise of the phonon-assisted absorption in each of the samples will occur at $E_{gx} + E_{ph}$. We use tunable laser excitation and scan it across and above the absorption edge. The luminescence is recorded in the region of the strongest free-exciton (FE) replica (cf. Fig. 2); the energy of the phonon responsible for this replica is 76.45 ± 0.05, 76.40 ± 0.05, and 76.25 ± 0.05 meV in $^{28}\text{Si}^{12}\text{C}$, natSiC and $^{13}\text{C}$-enriched samples, respectively. When the excitation energy is within ~1 meV above the absorption edge the sharp peak due to hot free-exciton recombination, $H_{76}$ [9], is visible, too, and allows accurate determination of $E_{gx}$. We obtain
the values $3265.8 \pm 0.1$, $3266.0 \pm 0.1$, and $3268.1 \pm 0.1$ meV for the excitonic bandgaps of $^{28}\text{Si}^{12}\text{C}$, $^{\text{nat}}\text{SiC}$, and $^{13}\text{C}$-enriched samples, respectively. The decrease of the bandgap with increasing content of heavier isotopes is in qualitative agreement with results obtained with isotope-controlled silicon, indicating that also in silicon carbide the electron-phonon interaction seems to be the dominant mechanism for the observed renormalization of the bandgap [10]. We notice that the shift of the excitonic bandgap accounts for most of the shift observed for the NBE lines and the phonon replicas in the spectra.

**Summary**

We present a comparative study of the optical properties of isotope-pure $^{28}\text{Si}^{12}\text{C}$ and samples with other isotope compositions. The shifts and the broadening of the Raman lines with increasing isotope disorder are clearly observed, as well as the shift of the phonons at the M-point of the Brillouin zone of 4H-$\text{SiC}$, as observed in the PL spectra. The excitonic bandgaps of the investigated samples are accurately determined. The observed increase in the bandgap with increasing isotope disorder is in qualitative agreement with the results for silicon and accounts for (most of) the shift of the NBE no-phonon lines.

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